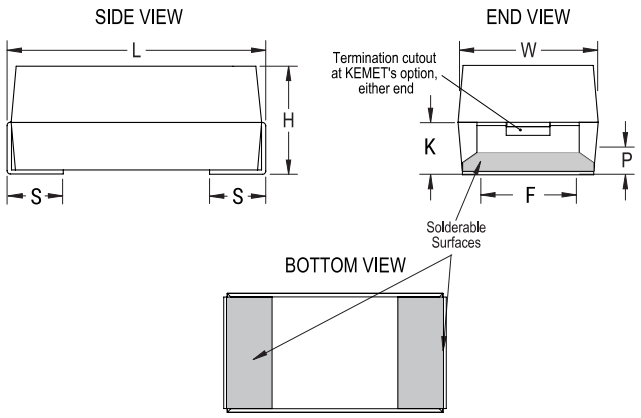
T497H156K025BH6411

T497 HRA, Tantalum, MnO2 Tantalum, HRA, 15 uF, 10%, 25 VDC, SMD, MnO2, Molded, High Reliability, Medical, B (0.1%/1000 Hrs), 1 Ohms, 7238, 3.17 mm, 1.27 mm



Click here for the 3D model.

General Information	
Series	T497 HRA
Dielectric	MnO2 Tantalum
Style	SMD Chip
Description	SMD, MnO2, Molded, High Reliability, Medical
Features	High Reliability, Medical
RoHS	No
Prop 65	**WARNING:** Cancer and reproductive harm - https://www.p65warnings.ca.gov/ .
SCIP Number	1dd2e1b8-26dd-4d52-927c-6f9d519011aa
Termination	Tin Lead (SnPb)
Qualifications	CWR09/19/29 Style
AEC-Q200	No
Typical Component Weight	349.01 mg
Miscellaneous	F1 Technology + Simulated Breakdown Screening (SBDS).
Notes	Note: When solder coated terminations are required, add an additional 0.38mm (0.015inch) to the tolerances for "L", "W", "H", "K" ,"F" and "S".
MSL	1

Dimensions	
L	7.24mm +/-0.38mm
W	3.81mm +/-0.38mm
H	2.79mm +/-0.38mm
S	1.27mm +0.25/-0.13mm
F	3.68mm +0.13/-0.51mm
K	1.52mm MIN
P	0.76mm MIN

Packaging Specifications	
Packaging	T&R, 178mm
Packaging Quantity	500

Specifications	
Capacitance	15 uF
Tolerance	10%
Voltage DC	25 VDC (85C), 16.75 VDC (125C)
Temperature Range	-55/+125°C
Rated Temperature	85°C
Humidity	85C, 85% RH, 1000 Hours, No Load
Dissipation Factor	6% 120Hz 25C
Failure Rate	B (0.1%/1000 Hrs)
ESR	1 Ohms (100kHz 25C)
Ripple Current	387 mA (rms, 100kHz 25C)
Leakage Current	3.8 uA (5min 25°C)
Testing and Reliability	10 Cycles Surge Current Testing At -55C And +85C